

Notice of References Cited	Application/Control No. 10/561,908		Applicant(s)/Patent Under Reexamination SUENAGA ET AL.	
	Examiner DAVID T. WELCH		Art Unit 2628	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	C	US-7,057,772 B1	06-2006	Bannai, Nobuyuki	358/3.01
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	L	US-			
	M	US-			

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
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